

Issue Classification

<i>Devin Hanan</i> 2/4/08 Devin Hanan 2/4/2008 (Assistant Examiner) (Date)	<i>Edward K. Look</i> EDWARD K. LOOK SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 3700 (Primary Examiner) (Date) 2/4/08	Total Claims Allowed: 9
(Legal Instruments Examiner) (Date)	O.G. Print Claim(s) 4	O.G. Print Fig. 5

<input type="checkbox"/> Claims renumbered in the same order as presented by applicant						<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original		Final	Original		Final	Original		Final	Original	
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2	2		32	62		92	122		152	182	
3	3		33	63		93	123		153	183	
4	4		34	64		94	124		154	184	
5	5		35	65		95	125		155	185	
6	6		36	66		96	126		156	186	
7	7		37	67		97	127		157	187	
8	8		38	68		98	128		158	188	
9	9		39	69		99	129		159	189	
10	10		40	70		100	130		160	190	
11	11		41	71		101	131		161	191	
12	12		42	72		102	132		162	192	
13	13		43	73		103	133		163	193	
14	14		44	74		104	134		164	194	
15	15		45	75		105	135		165	195	
16	16		46	76		106	136		166	196	
17	17		47	77		107	137		167	197	
18	18		48	78		108	138		168	198	
19	19		49	79		109	139		169	199	
20	20		50	80		110	140		170	200	
21	21		51	81		111	141		171	201	
22	22		52	82		112	142		172	202	
23	23		53	83		113	143		173	203	
24	24		54	84		114	144		174	204	
25	25		55	85		115	145		175	205	
26	26		56	86		116	146		176	206	
27	27		57	87		117	147		177	207	
28	28		58	88		118	148		178	208	
29	29		59	89		119	149		179	209	
30	30		60	90		120	150		180	210	